Machine learning

Probabilistic Discriminative Classifiers

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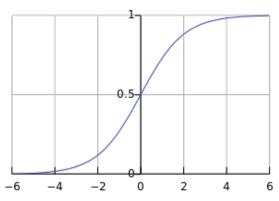
Introduction



▶ Bayes classifier for two classes C_1 and C_2

$$\begin{split} \rho(C_1|X) &= \frac{P(X|C_1)P(C_1)}{P(X)} = \frac{P(X|C_1)P(C_1)}{p(X|C_1)p(C_1) + p(X|C_2)p(C_2)} \\ &= \frac{1}{1 + \frac{p(X|C_2)p(C_2)}{P(X|C_1)P(C_1)}} = \frac{1}{1 + \exp(-a)} = \sigma(a) \\ a &= \ln \frac{P(X|C_1)P(C_1)}{P(X|C_2)P(C_2)} \end{split}$$

where $\sigma(x)$ refers to sigmoid function.



Introduction (cont.)



Let the class conditional densities be D-dimensional Gaussian (for k = 1, 2)

$$p(x|C_k) = \mathcal{N}(\mu, \Sigma) = \frac{1}{|\Sigma|^{D/2} (2\pi)^{D/2}} exp\left(-\frac{1}{2}(x - \mu_k)^{\top} \Sigma^{-1}(x - \mu_k)\right)$$

Hence a equals to

$$\begin{split} a &= \ln \frac{P(X|C_1)P(C_1)}{P(X|C_2)P(C_2)} \\ &= \ln \frac{exp\left(-\frac{1}{2}(x-\mu_1)^{\top}\Sigma^{-1}(x-\mu_1)\right)}{exp\left(-\frac{1}{2}(x-\mu_2)^{\top}\Sigma^{-1}(x-\mu_2)\right)} \frac{P(C_1)}{P(C_2)}. \end{split}$$

Hence, we have

$$P(C_1|X) = \sigma(W^{\top}X + w_0)$$

where

$$\begin{split} W &= \Sigma^{-1}(\mu_1 - \mu_2) \\ w_0 &= -\frac{1}{2}\mu_1^\top \Sigma^{-1} \mu_1 + \frac{1}{2}\mu_2^\top \Sigma^{-1} \mu_2 + \ln \frac{P(C_1)}{P(C_2)} \end{split}$$

or simply

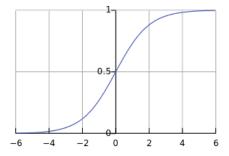
$$P(C_1|X) = \sigma\left(W'^{\top}X\right)$$

Introduction (cont.)



▶ We compute a linear combination of the inputs but then we pass through a function that ensures $0 \le y_n \le 1$ by defining.

$$y_n = \sigma(w^\top x) \triangleq \frac{1}{1 + \exp(-w^\top x)}.$$



- ▶ If we find *W* directly, we need to find *D* parameters.
- ▶ If we find $P(C_k|X)$ via probabilistic modeling of data using Gaussian distribution and MLE, we need
 - 1. 2D parameters for mean
 - 2. $\frac{D(D+1)}{2}$ parameters for shared covariance matrix
 - 3. One parameter for $P(C_1)$ resulting $\frac{D(D+5)}{2} + 1$ parameters.
- ► This results in Logistic regression classifier.

Logistic regression



- Logistic regression is a model for probabilistic classification.
- ▶ It predicts label probabilities rather than a hard value of the label.
- ▶ Let

$$y_n = P(C_1|x_n)$$
$$1 - y_n = P(C_2|x_n)$$

▶ The output of Logistic regression is a probability defined using the sigmoid function

$$P(C_1|x_n) = y_n = \sigma(W^{\top}x_n)$$

$$= \frac{1}{1 + exp(-W^{\top}x_n)}$$

► The log of the ratio of probabilities $\ln \frac{P(C_1|x_n)}{P(C_2|x_n)}$ for the two classes, also known as the log odds equals to

$$\ln \frac{P(C_1|x_n)}{P(C_2|x_n)} = \ln \exp (W^{\top}x_n)$$
$$= W^{\top}x_n$$

▶ Thus if $W^{\top}x_n > 0$, the probable class is C_1 .



▶ One loss function may be

$$\ell(t_n, h(x_n)) = (t_n - h(x_n))^2$$

This loss function is not a convex function and is not easy to optimize.

▶ The likelihood function can be written

$$p(t|w) = \begin{cases} y_n & t_n = 1\\ (1 - y_n) & t_n = 0 \end{cases}$$

- ▶ If $t_n = 1$ but y_n is close to 0 then loss will be high.
- ▶ If $t_n = 0$ but y_n is close to 1 then loss will be high.
- ▶ The likelihood function can also be written

$$p(t|w) = y_n^{t_n} (1 - y_n)^{(1-t_n)}$$

▶ We can define a loss function by taking the negative logarithm of the likelihood.

$$\mathcal{L}(W) = -\ln \prod_{n=1}^{N} \ell(t_n, h(x_n)) = -\sum_{n=1}^{N} [t_n \ln y_n + (1 - t_n) \ln(1 - y_n)]$$

► This loss function is called the cross-entropy loss.



▶ Let $t_n \in \{-1, +1\}$. Another way to write the log-likelihood of data is.

$$p(+1|x) = \frac{1}{1 + \exp(-w^{\top}x)}$$

 $p(-1|x) = \frac{1}{1 + \exp(+w^{\top}x)}$

By combining the above equations and computing negative log-likelihood of data, we obtain

$$\mathcal{L}(w) = -\sum_{n=1}^{N} \ln \frac{1}{1 + \exp(-t_n w^{\top} x_n)}$$
$$= \sum_{n=1}^{N} \ln \left[1 + \exp(-t_n w^{\top} x_n) \right]$$

Unlike linear regression, we can no longer write down the minimum of negative log-likelihood in the closed form. Instead, we need to use an optimization algorithm for computing it.



 \triangleright Computing the gradients of L(w) with respect to w, we obtain

$$\nabla \mathcal{L}(w) = \sum_{n=1}^{N} t_n x_n (y_n - t_n)$$

Updating the weight vector using the gradient descent rule will result in

$$W^{(k+1)} = W^{(k)} - \eta \sum_{n=1}^{N} t_n x_n (y_n - t_n)$$

 η is the learning rate.

▶ In order to have a good trade-off between the training error and the generalization error, we can add the regularization term.

$$\mathcal{L}(w) = \sum_{n=1}^{N} \log \left[1 + \exp(-t_n w^{\top} x_n) \right] + \frac{\lambda}{2} ||w||^2$$

Using the gradient descent rule, will result in the following updating rule.

$$W^{(k+1)} = W^{(k)} - \eta \sum_{n=1}^{N} t_n x_n (y_n - t_n) - \lambda W^{(k)}$$

MLE formulation of Logistic regression



▶ In linear regression, we often assume that the noise has a Gaussian distribution.

$$p(t|x, w) = \mathcal{N}(t|\mu(x), \sigma^2(x))$$

- ▶ We can generalize the linear regression to binary classification by making two changes:
 - First, replacing the Gaussian distribution for t with Bernoulli distribution, which is more appropriate for classification.

$$p(t_n|x_n,w) = Ber(t_n|y_n) = \begin{cases} y_n & \text{if } t_n = 1 \\ 1-y_n & \text{if } t_n = 0 \end{cases}$$

where $\mu(x_n) = \mathbb{E}[t_n|x_n] = p(t_n = 1|x_n)$.

► This is equivalent to

$$p(t_n|x_n, w) = Ber(t_n|\mu(x_n)) = \mu(x_n)^{t_n}(1 - \mu(x_n))^{(1-t_n)}$$

Second, compute a linear combination of the inputs and then we pass this through a function that ensures $0 \le \mu(x) \le 1$ by defining

$$\mu(x) = \sigma(w^{\top}x)$$



 \triangleright Putting these two steps together and dropping index n, we obtain

$$p(t|x, w) = Ber(t|\sigma(w^{T}x)).$$

- ▶ This is called logistic regression due to its similarity to linear regression.
- If we threshold the output probability at $\frac{1}{2}$, we can introduce a decision rule of the form

if
$$p(t = 1|x) > 0.5 \iff h(x) = 1$$
.

- Logistic regression learns weights so as to maximize the (log-)likelihood of the data.
- Let $S = \{(x_1, t_1), (x_2, t_2), \dots, (x_N, t_N)\}$ be the training set. The negative log-likelihood of data equals

$$\mathcal{L}(w) = -\ln \prod_{n=1}^{N} y_n^{t_n} (1 - y_n)^{(1 - t_n)}$$
$$= -\sum_{n=1}^{N} t_n \ln y_n + (1 - t_n) \ln(1 - y_n)$$

This is called the cross-entropy error function.

MAP formulation of Logistic regression



- ▶ Maximum likelihood estimate of *W* can lead to overfitting when data set is linearly separable. A solution is to use a prior on *w*.
- ▶ This can be avoided by inclusion of a prior and finding a MAP solution or equivalently by adding a regularization term to the error function.
- ► Same as linear regression, we consider a Gaussian prior on w

$$p(W) = \mathcal{N}(0, \sigma_0^2 I_D).$$

▶ I_D denotes the $D \times D$ identity matrix. This is equivalent to assume that the prior selects each component of W independently from a $\mathcal{N}(0, \sigma_0^2)$. This prior can be written as

$$ho(W) = rac{1}{(2\pi)^{D/2}\sigma_0^D} exp \left\{ -rac{1}{2\sigma_0^2} ||W||_2^2
ight\}.$$



Assume that noise precision is known, The posterior density of W given set S and solving the equation gives the form

$$\mathcal{L}(w) = \sum_{n=1}^{N} \log \left[1 + \exp(-t_n w^{ op} x_n)
ight] + rac{\lambda}{2} \|w\|^2$$

- ► Thus MAP estimation is equivalent to regularized logistic regression.
- ▶ Using the gradient descent rule, will result in the following updating rule.

$$W^{(k+1)} = W^{(k)} - \eta \sum_{n=1}^{N} t_n x_n (y_n - t_n) - \lambda W^{(k)}$$

Reading

Readings



- 1. Sections 4.3.2 of Pattern Recognition and Machine Learning Book (Bishop 2006).
- 2. Chapter 8 of Machine Learning: A probabilistic perspective (Murphy 2012).
- 3. Chapter 10 of Probabilistic Machine Learning: An introduction (Murphy 2022).

References i



Bishop, Christopher M. (2006). Pattern Recognition and Machine Learning. Springer-Verlag.

Murphy, Kevin P. (2012). Machine Learning: A Probabilistic Perspective. The MIT Press.

- (2022). Probabilistic Machine Learning: An introduction. The MIT Press.

Questions?





